

Novel Vapor-phase Synthesis of Homogeneous Organic-Inorganic Hybrid films and its Application to electronic devices

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Organic-inorganic hybrid dielectrics have attracted considerable attention for improving both the dielectric constant ( $k$ ) and the mechanical flexibility of the gate dielectric layer for emerging flexible and wearable electronics. This study proposes a novel vapor-phase synthesis method to form an ultra-thin, homogeneous, high- $k$  organic-inorganic hybrid dielectric. A series of hybrid dielectrics is synthesized via initiated chemical vapor deposition (iCVD) in a one-step manner. The thickness and composition are effectively controlled to form a uniform, defect-free hybrid dielectric. As a result, the synthesized hybrid dielectric has a high- $k$  value of as high as 7 and exhibits a low leakage current density of less than  $3 \times 10^{-7}$  A/cm at 2 MV/cm. Furthermore, the dielectric layer shows exceptional chemical stability without any degradation in its dielectric performance and a smooth surface morphology. Organic thin film transistors with the developed hybrid dielectric as the gate dielectric achieved hysteresis-free transfer characteristics with an operating voltage of up to 4 V and excellent mechanical flexibility as well.